



03560.002732.

PATENT APPLICATION

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)	
Masato MURAKI et al.)	Examiner: K. Fernandez
Application No.: 09/708,590)	Group Art Unit: 2881
Filed: November 9, 2000)	
For: CORRECTING METHOD FOR CORRECTING EXPOSURE DATA USED: FOR A CHARGED PARTICLE BEAM EXPOSURE SYSTEM)	January 30, 2003

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COMMISSIONER FOR PATENTS
Washington, D.C. 20231

Sir:

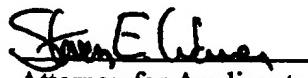
Transmitted herewith is a Supplemental Preliminary Amendment in the above-identified application.

No additional fee is required.

The fee has been calculated as shown below:

- °Verified Statement claiming small entity status is enclosed, if not filed previously.
- A check in the amount of \$84.00 is enclosed.
- Charge \$____ to Deposit Account No. 06-1205. A duplicate of this sheet is enclosed.
- Any prior general authorization to charge an issue fee under 37 C.F.R. § 1.18 to Deposit Account No. 06-1205 is hereby revoked. The Commissioner is hereby authorized to charge any additional fees under 37 C.F.R. §§ 1.16 and 1.17 which may be required during the entire pendency of this application, or to credit any overpayment, to Deposit Account No. 06-1205. A duplicate of this paper is enclosed.
- A check in the amount of \$____ to cover the Extension fee for response within ____ additional months is enclosed.
- A check in the amount of \$____ to cover the Information Disclosure Statement fee is enclosed.
- Applicants' undersigned attorney may be reached in our Washington, D.C. office by telephone at (202) 530-1010. All correspondence should continue to be directed to our address given below.

Respectfully submitted,


Attorney for Applicants
Steven E. Warner
Registration No. 33,326

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SEW/eab